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## B.Tech. – VIEP – MECHANICAL ENGINEERING (BTMEVI)

Term-End Examination June, 2018

## **BIME-005 : MATERIAL SCIENCE**

Time : 3 hours

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Maximum Marks : 70

**Note :** Attempt any **five** questions. All questions carry equal marks.

- (a) Describe briefly the classification of materials. Distinguish between an alloy and a compound.
  - (b) Define Plasticity. Describe the elastic or inelastic behaviour of materials with the help of a stress-strain diagram.
- **2.** (a) Describe in brief the time-temperature transformation curve for steel.
  - (b) Describe the behaviour of electrical conductivity in ceramics. Also explain the behaviour of superconductivity in metals and alloys.

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- **3.** (a) What is Atomic Packing Factor ? Calculate the atomic packing factor for a hexagonal closed packed and face-centred cube crystal system.
  - (b) Distinguish between fatigue failure and fatigue strength. Briefly explain the measures that may be taken to increase the resistance dto fatigue failure of a metal/alloy.

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- **4.** (a) Distinguish between the structure and properties of thermosetting and thermoplastic resins.
  - (b) Explain the mechanism of crack initiation and growth when a metal is subjected to cyclic loading.
- 5. With the help of a neat sketch, explain the working of a ablast furnace. Also list out its applications, advantages and limitations.
- 6. (a) Describe the phenomenon of superconductivity. Discuss the features of Type-I and Type-II superconductors.
  - (b) State how carbon content influences the strength and ductility of plain carbon steels.

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- 7. (a) Define Toughness. Explain how the toughness of a material is measured.
  - (b) How do mechanical pdroperties change during the hardening and tempering process ?
- 8. Write short notes on any *four* of the following:  $4 \times 3\frac{1}{2} = 14$ 
  - (a) Chemical Bonding
  - (b) Annealing
  - (c) Cold Workinag Process
  - (d) Non-destructive Testing
  - (e) Doping in Semiconductors
  - (f) Applications of Nano Materials

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